

# P-Channel 80-V (D-S) 175 °C MOSFET

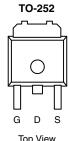
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$r_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ)	
- 80	$0.0252$ at $V_{GS} = -10 \text{ V}$	- 50	55 nC	
	$0.029 \text{ at V}_{GS} = -4.5 \text{ V}$	- 47	55 HC	

Ordering Information: SUD50P08-25L-E3 (Lead (Pb)-free)

### **FEATURES**

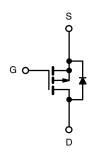
• TrenchFET® Power MOSFET





Drain Connected to Tab

Top View



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	$T_A = 25  ^{\circ}C$ , unle	ess otherwise no	ted	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	- 80	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20	v	
	T <sub>C</sub> = 25 °C		- 50 <sup>a</sup>	
Continuous Drain Current (T. – 175 °C)	T <sub>C</sub> = 70 °C	1 , [	- 42.5 <sup>a</sup>	
Continuous Drain Current (T <sub>J</sub> = 175 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 12.5 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		- 10.5 <sup>b, c</sup>	A
Pulsed Drain Current		I <sub>DM</sub>	- 40	^
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I-	- 50 <sup>a</sup>	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	l <sub>S</sub>	- 6.9 <sup>b, c</sup>	
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	- 45	
Single-Pulse Avalanche Energy	L = 0.1 IIII	E <sub>AS</sub>	101	mJ
	T <sub>C</sub> = 25 °C		136	
Marian and David Disability	T <sub>C</sub> = 70 °C	P <sub>D</sub>	95	10/
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		8.3 <sup>b, c</sup>	— w
	T <sub>A</sub> = 70 °C		5.8 <sup>b, c</sup>	
Operating Junction and Storage Temperature Ra	ange	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 sec	$R_{thJA}$	15	18	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	0.85	1.1			

Notes:
a. Package limited.
b. Surface mounted on 1" x 1" FR4 board.

c. t=10 sec. d. Maximum under steady state conditions is 40 °C/W.

## SUD50P08-25L

# Vishay Siliconix



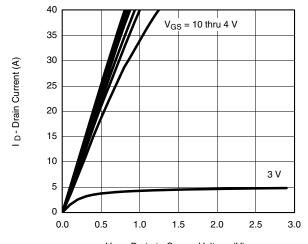
<b>SPECIFICATIONS</b> $T_J = 25$ °C, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit		
Static								
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$	- 80			V		
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 73		mV/°C		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	10 = 200 μΑ		- 5.5				
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V		
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA		
Zava Cata Valta va Dvaira Coverant	lass	V <sub>DS</sub> = - 80 V, V <sub>GS</sub> = 0 V			- 1			
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 80 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10	μΑ		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = -10 \text{ V}$				Α		
Drain-Source On-State Resistance <sup>a</sup>	,	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 12.5 A		0.021	0.0252			
	r <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 10.5 A		0.024	0.029	Ω		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 12.5 A		52		S		
Dynamic <sup>b</sup>				•	•			
Input Capacitance	C <sub>iss</sub>			4700		pF		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 40 V, V <sub>GS</sub> = 0 V, f = 1 MHz		320				
Reverse Transfer Capacitance	C <sub>rss</sub>	1		235				
Total Oats Observe	0	V <sub>DS</sub> = -40 V, V <sub>GS</sub> = -10 V, I <sub>D</sub> = -12.5 A		105	160	nC		
Total Gate Charge	Qg			55	85			
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -40 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -12.5 \text{ A}$		16				
Gate-Drain Charge	$Q_{gd}$			26				
Gate Resistance	$R_{g}$	f = 1 MHz		4		Ω		
Turn-On Delay Time	t <sub>d(on)</sub>			45	70			
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 40 V, $R_L$ = 3.8 $\Omega$		220	330	ns		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10.5 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		95	145			
Fall Time	t <sub>f</sub>	1		110	165			
Turn-On Delay Time	t <sub>d(on)</sub>			15	25			
Rise Time	t <sub>r</sub>	$V_{DD} = -40 \text{ V}, R_{L} = 3.8 \Omega$		25	40	ns		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10.5 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		105	160			
Fall Time	t <sub>f</sub>	1		100	150			
Drain-Source Body Diode Characteristic	s			•	•			
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 50	А		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 40	_ ^		
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 10.5 A		- 0.8	- 1.2	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			55	85	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	10.5 4 di/dt 100.4/ T 05.00		110	165	nC		
Reverse Recovery Fall Time	ta	$I_F = -10.5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		37				
Reverse Recovery Rise Time	t <sub>b</sub>	_		18		ns		

- a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

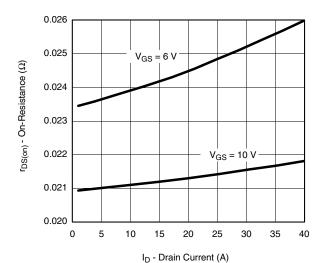
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



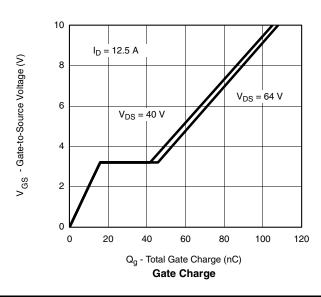
## TYPICAL CHARACTERISTICS 25 °C unless noted



V<sub>DS</sub> - Drain-to-Source Voltage (V) **Output Characteristics** 

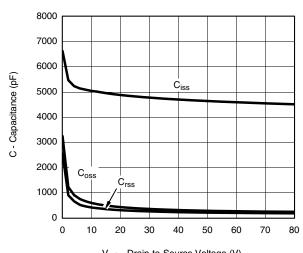


On-Resistance vs. Drain Current and Gate Voltage

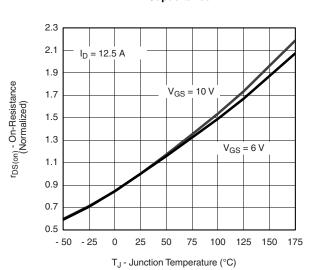


20 16 12 12 12 T<sub>A</sub> = 125 °C 25 °C 0.0 0.5 1.0 1.5 2.0 2.5 3.0 3.5

V<sub>GS</sub> - Gate-to-Source Voltage (V) **Transfer Characteristics** 



V<sub>DS</sub> - Drain-to-Source Voltage (V) **Capacitance** 



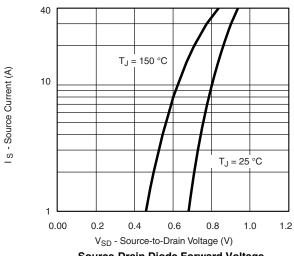
On-Resistance vs. Junction Temperature

## SUD50P08-25L

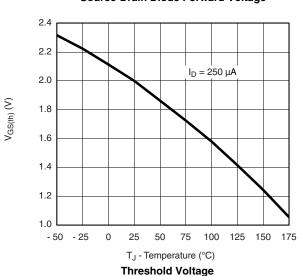
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## TYPICAL CHARACTERISTICS 25 °C unless noted



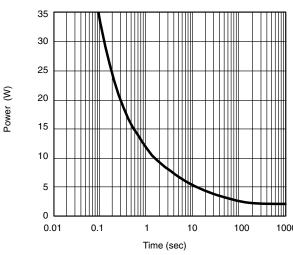


Source-Drain Diode Forward Voltage

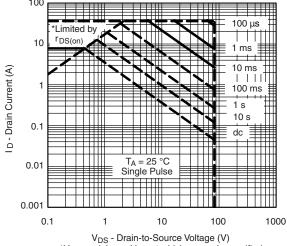


0.05  $r_{\text{DS(on)}}$  - Drain-to-Source On-Resistance  $(\Omega)$ 0.04 T<sub>A</sub> = 125 °C 0.03  $T_A = 25$  °C 0.02 0.01 2 6 9 10 V<sub>GS</sub> - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

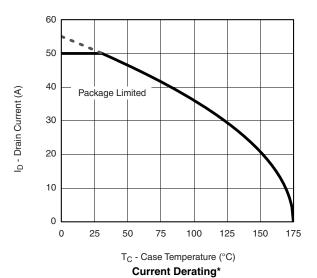


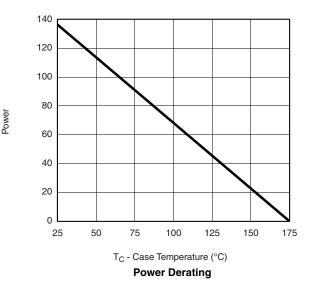
 $^*V_{GS}$  > minimum  $V_{GS}$  at which  $r_{DS(on)}$  is specified

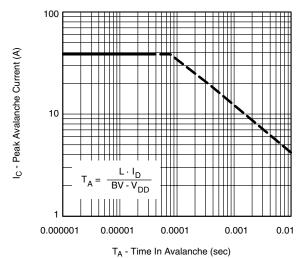
Safe Operating Area, Junction-to-Ambient



## TYPICAL CHARACTERISTICS 25 °C unless noted





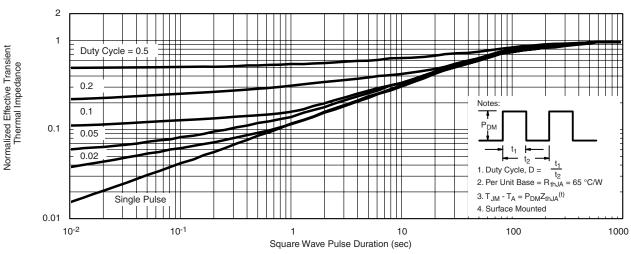


Single Pulse Avalanche Capability

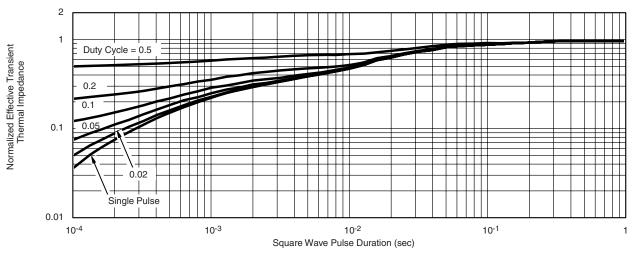
\*The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 175 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



### TYPICAL CHARACTERISTICS 25 °C unless noted



### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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